Search Notes

Application/Control No.	No. Applicant(s)/Patent under Reexamination	
10/720,263	NAGAMI ET AL.	
Examiner	Art Unit	
CHUONG T. HO	2616	

SEARCHED					
Class	Subclass	Date	Examiner		
370 370	392 v	06/20/07	, CH		
370	401 V				
370	397 V				
370	395.21	,			
370	399 V				
370	352 V				
709	238v				
709	240 V				
709	2411				
709	242 v	•	V		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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